

$^{64}\text{Se} \epsilon\text{p decay (22.6 ms)}$ **2019Ru07**

Type	Author	History Citation	Literature Cutoff Date
Full Evaluation	Jun Chen	NDS 196,17 (2024)	30-Sep-2023

Parent: ^{64}Se : E=0; $J^\pi=0^+$; $T_{1/2}=22.6$ ms 2; $Q(\epsilon\text{p})=12770$ syst; % ϵp decay=?

$^{64}\text{Se-T}_{1/2}$: From implant-proton correlation in [2019Ru07](#).

$^{64}\text{Se-Q}(\epsilon\text{p})$: 12770 500 (syst,[2021Wa16](#)).

[2019Ru07](#): ^{64}Se source was produced by fragmentation of E=350 MeV/nucleon ^{78}Kr beam on a ^9Be target at RIKEN. Fragments were separated and selected with the BigRIPS separator and implanted into the WAS3ABi device consisting of 3 DSSSDs, surrounded by the EURICA array. Measured E_γ , $E(p)$, implant- p and implant- β correlations. Deduced parent levels, decay $T_{1/2}$.

All data are from [2019Ru07](#), unless otherwise noted.

Note that results from [2019Ru07](#) are preliminary as stated by the authors.

 ^{63}Ge Levels

E(level)	J^π	$T_{1/2}$	Comments
0	$(3/2^-)$	153.3 ms 6	J^π : from Adopted Levels. $T_{1/2}$: from implant- $\beta(t)$ in 2019Ru07 .
417.5 1			

 $\gamma(^{63}\text{Ge})$

E_γ	$E_i(\text{level})$	E_f	J_f^π
417.5 1	417.5	0	$(3/2^-)$

Delayed Protons (^{63}Ge)

$E(p)^\dagger$	$E(^{63}\text{Ge})$	$E(^{64}\text{As})$
604 58	0	507.1
1580 36	417.5	1956.4
1986 34	0	1956.4
3262 44	0	3.16×10^3
3721 58	0	3.62×10^3
4001 66	0	3.90×10^3
4602 57	0	4.50×10^3

[†] From the decay scheme in Figure 6 of [2019Ru07](#). Note that $E(p)$ values are also given in the proton spectrum of ^{64}Se decay in Figure 4, but none of them match the value quoted here.

^{64}Se ϵp decay (22.6 ms) 2019Ru07Decay Scheme